

# ASSET - Photocathode characterisation device

Overview of the setup and measurement capabilities

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RD51 MINI-WEEK

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# Introduction

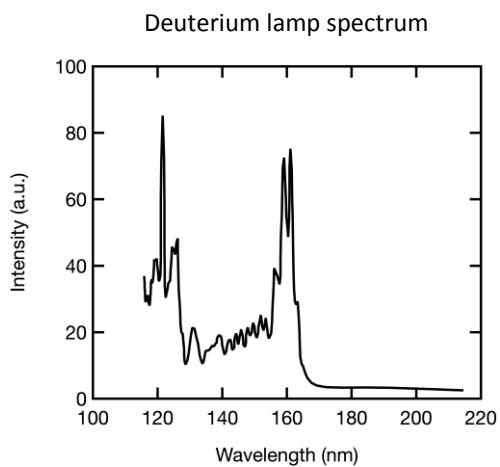
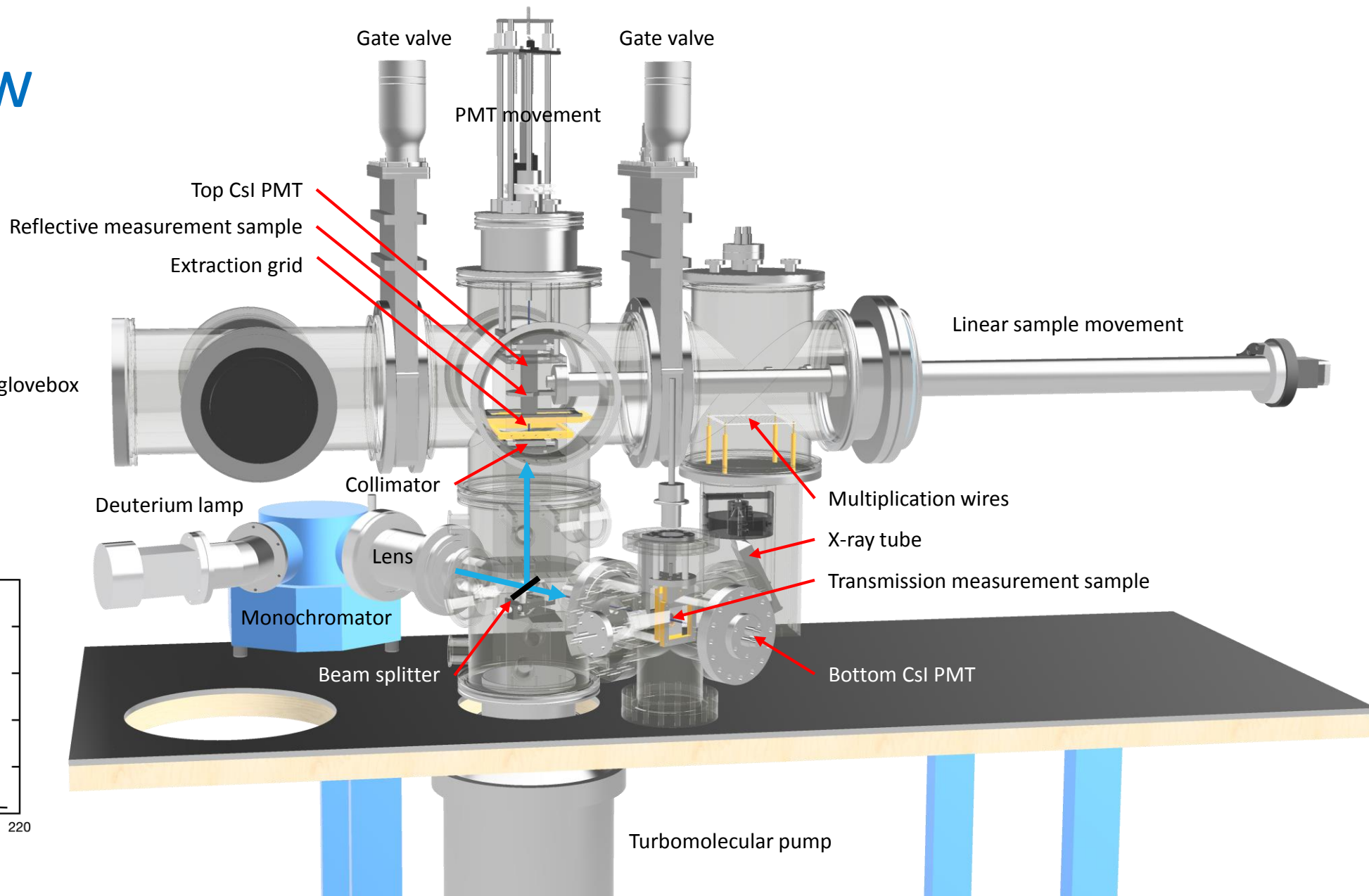
- Motivation:
  - Robust photocathodes for use with precise timing Micromegas.
- The PicoSec project:
  - *Reference, L. Sohl: <https://indico.cern.ch/event/872501/contributions/3726013/>*
  - The detector uses semi-transparent CsI photocathodes (18 nm) on MgF<sub>2</sub> crystals.
  - Degradation of CsI QE is a concern in the development of this concept.
- Goals:
  - Quantify the degradation of photocathodes when exposed to ion back flow.
  - Examine possible alternative photocathode materials as well as protective layers.

# ASSET

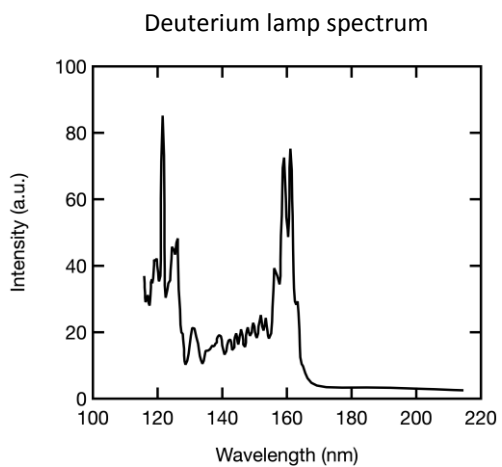
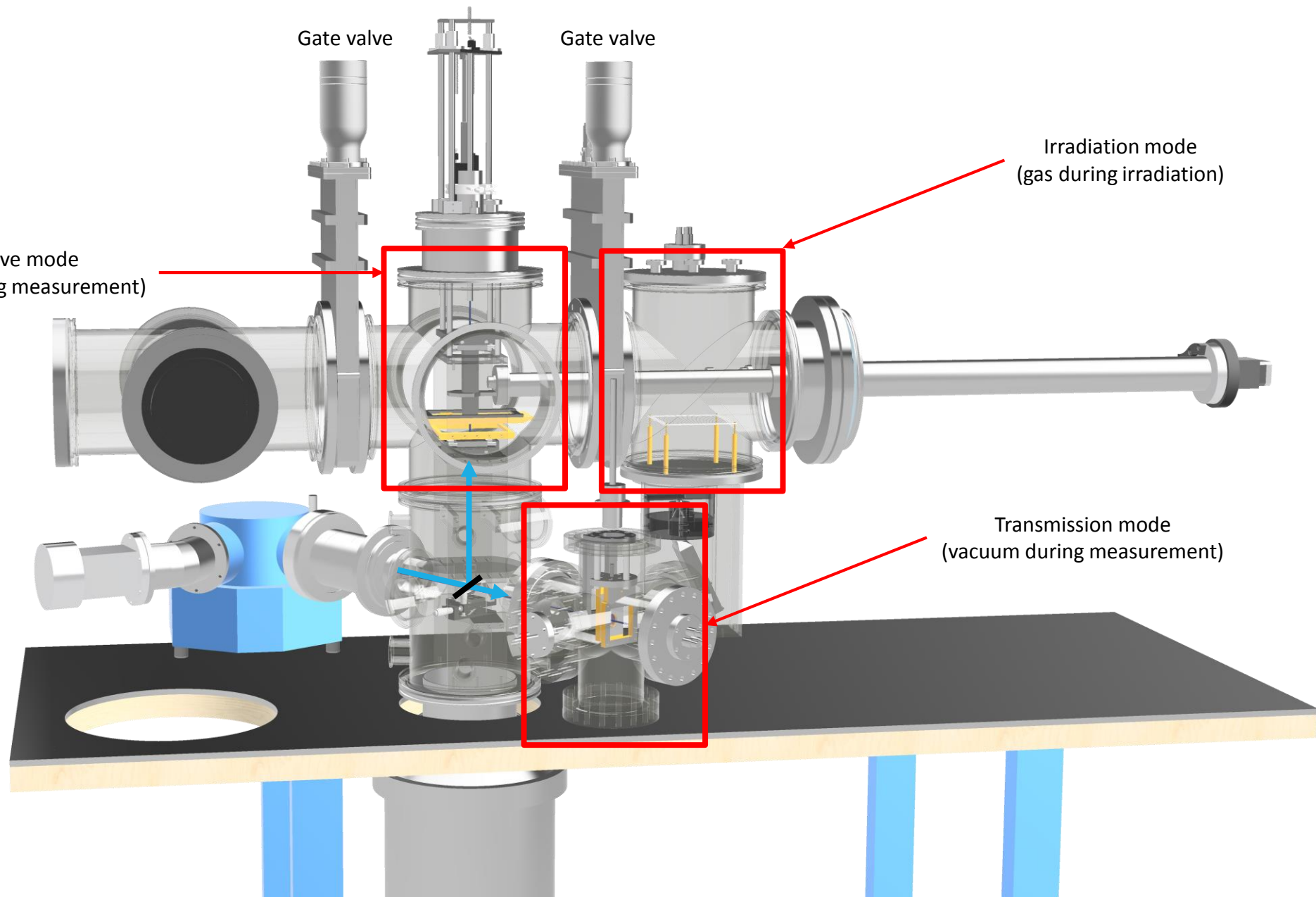
## Overview of the setup

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# Overview

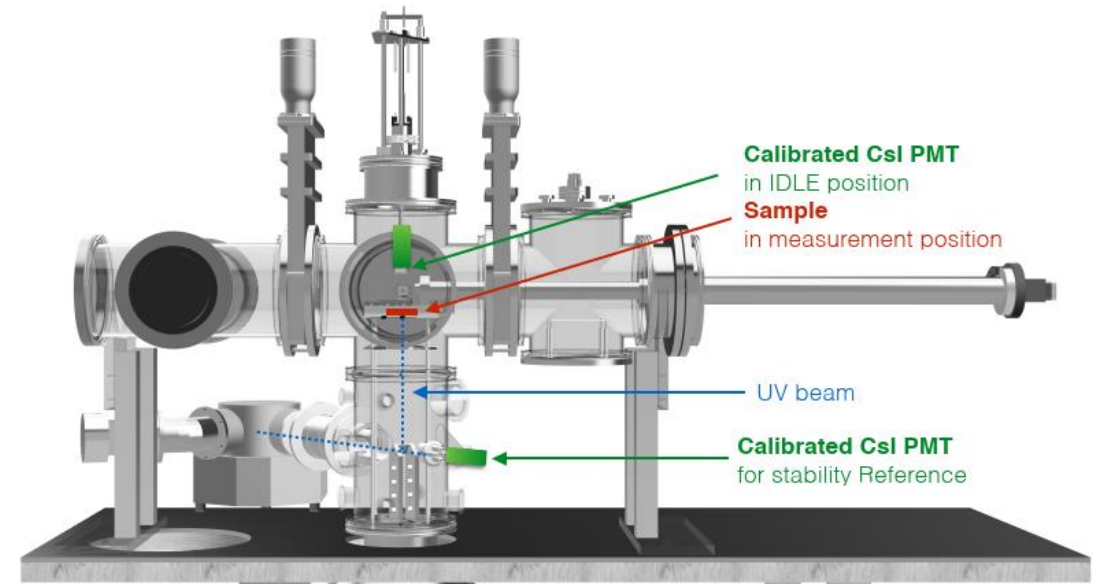
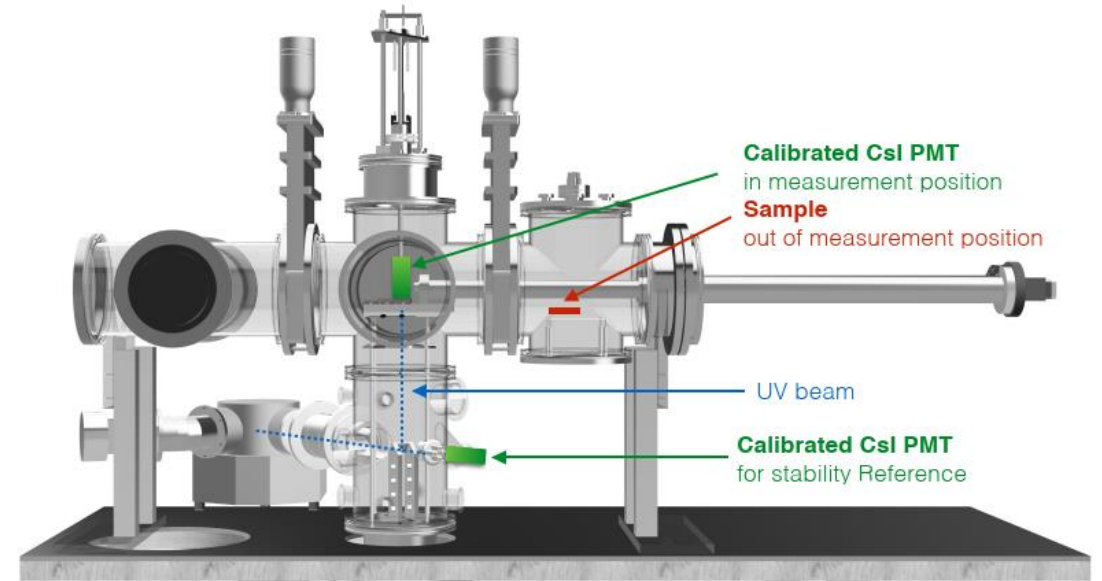
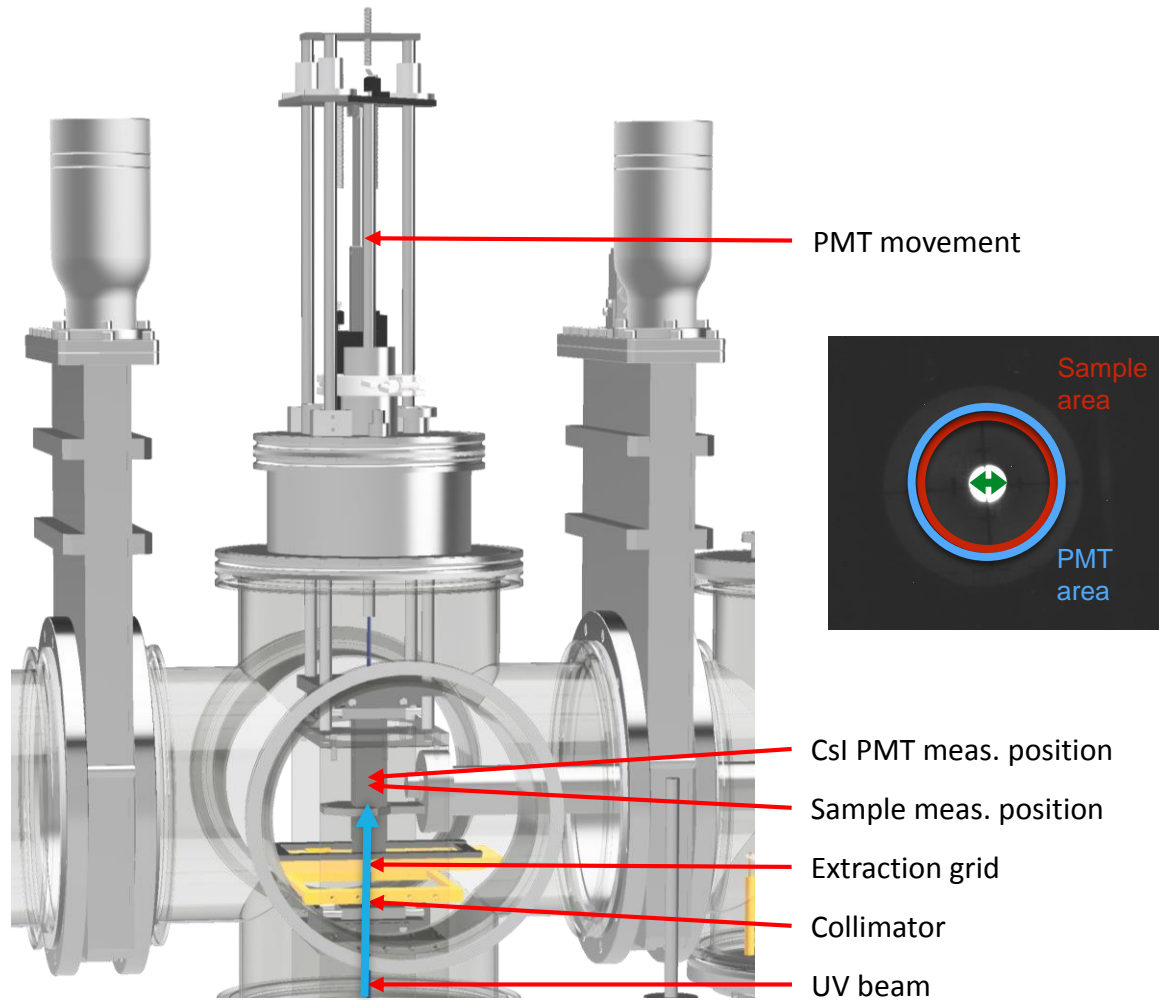


# Overview



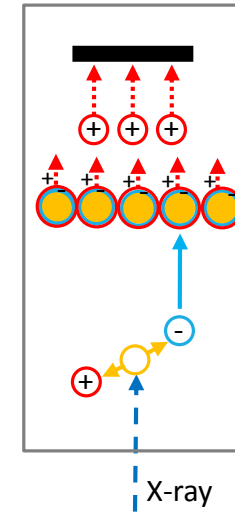
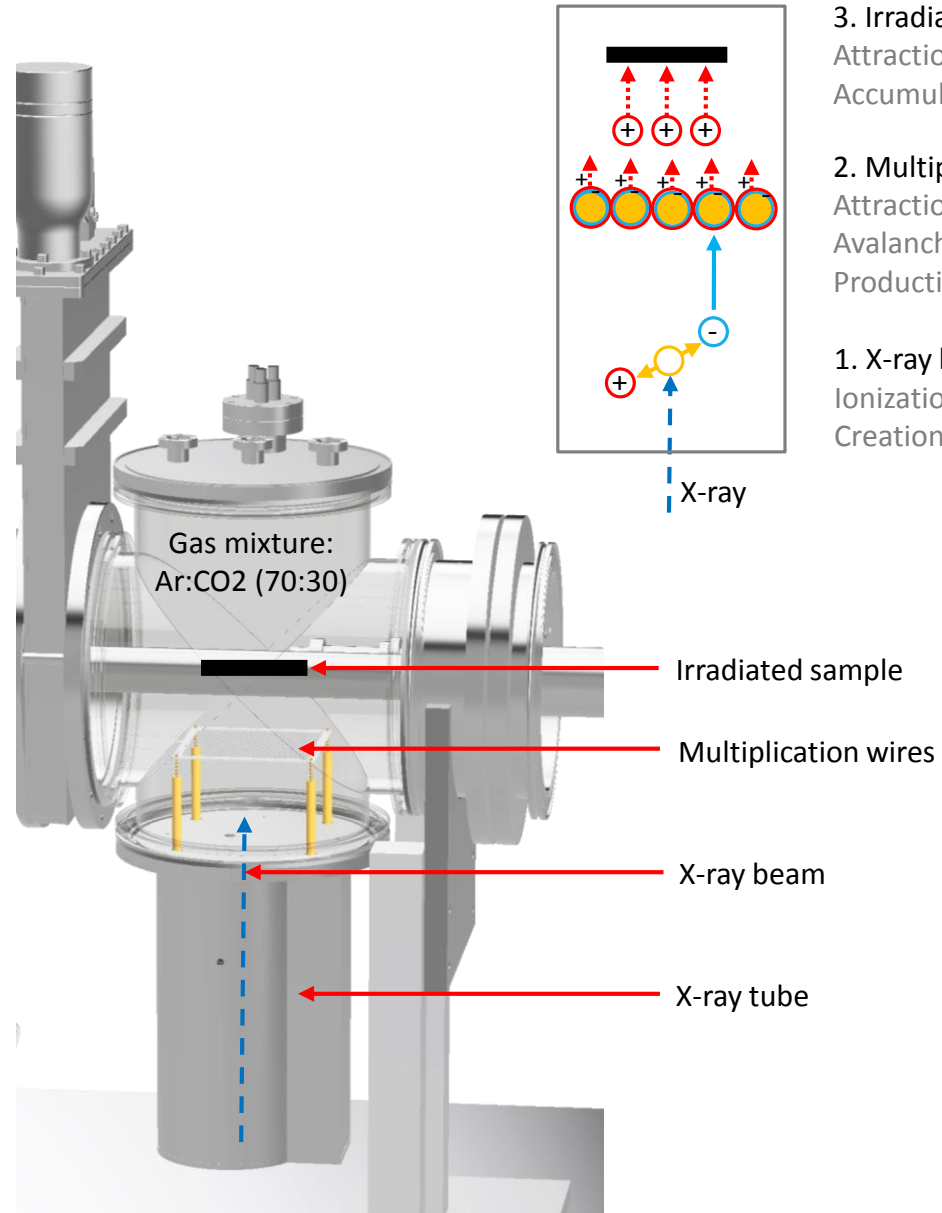
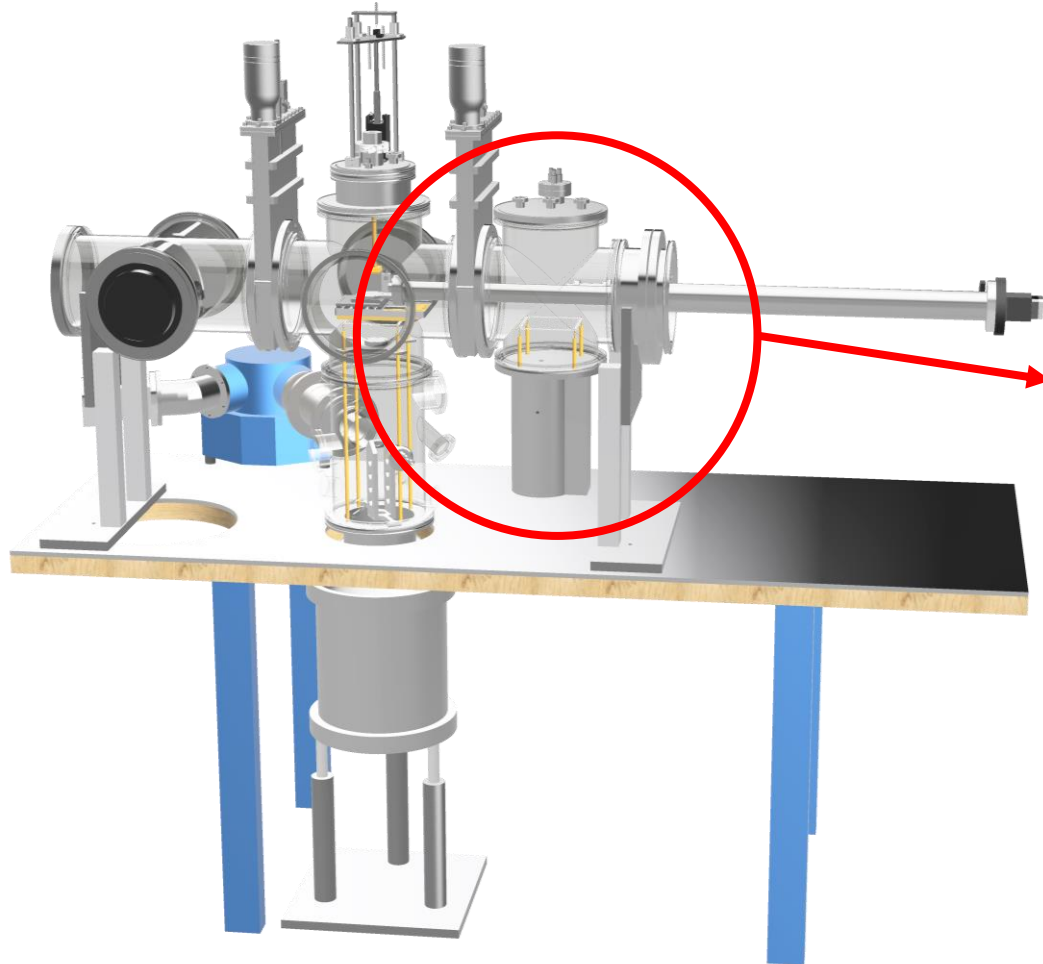
# Reflective mode

Vacuum during measurement



# Irradiation mode

Gas during irradiation



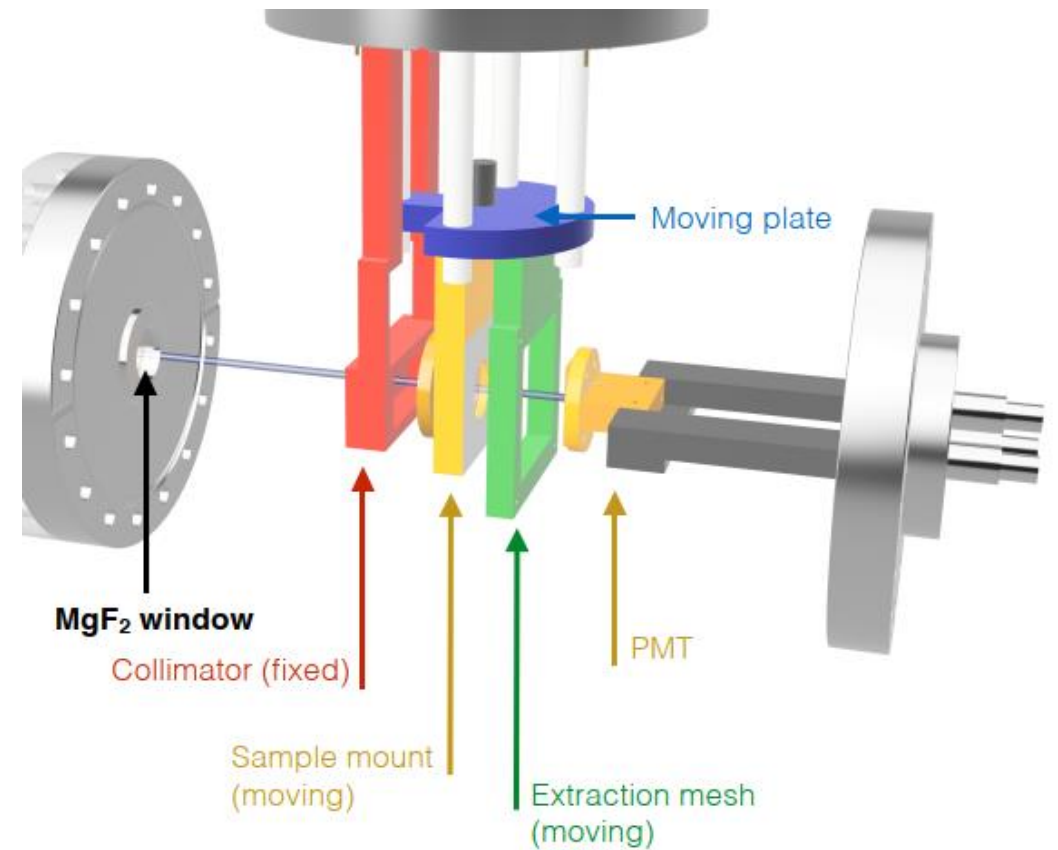
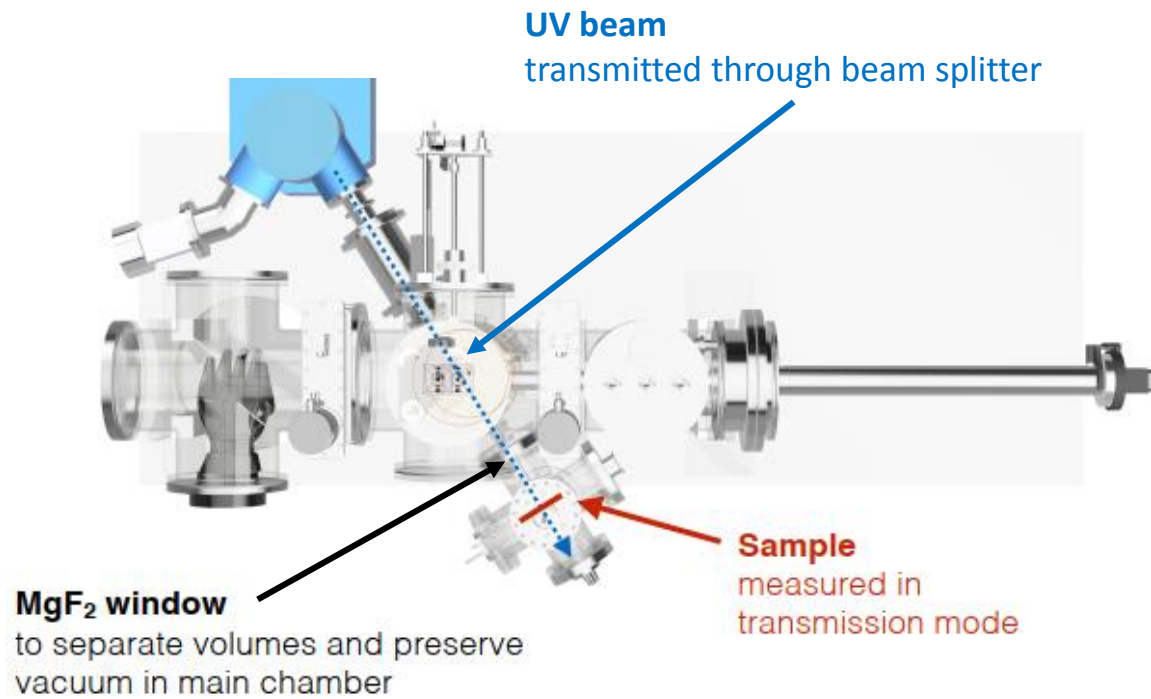
3. Irradiated sample (grounded):  
Attraction of ions from avalanche  
Accumulation of charge

2. Multiplication wires (positive HV):  
Attraction of primary electrons  
Avalanche multiplication  
Production of electrons and ions

1. X-ray beam in a gas chamber:  
Ionization of particles  
Creation of primary charge

# Transmission mode

Vacuum during measurement





# ASSET

## Measurement capabilities

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# Photocurrent, QE, transparency measurements

## Reflective/Transmission mode

- Measurement of photocurrent and calculation of QE (both modes) and transparency (only transmission mode).

$$QE = \frac{Electrons_{sample}}{Photons_{PMT}} = \frac{\frac{I_{sample}}{e}}{\frac{Electrons_{PMT}}{CalFac_{PMT}}} = \frac{\frac{I_{sample}}{e}}{\frac{I_{PMT}}{e \cdot CalFac_{PMT}}} = \frac{I_{sample} \cdot CalFac_{PMT}}{I_{PMT}}$$

$Electrons_{sample}$  - electrons extracted from sample (measured on sample in meas. position)

$Photons_{PMT}$  - photons that arrived to sample (measured on PMT in meas. position)

$I_{sample}$  - current measured on sample (offset subtracted)

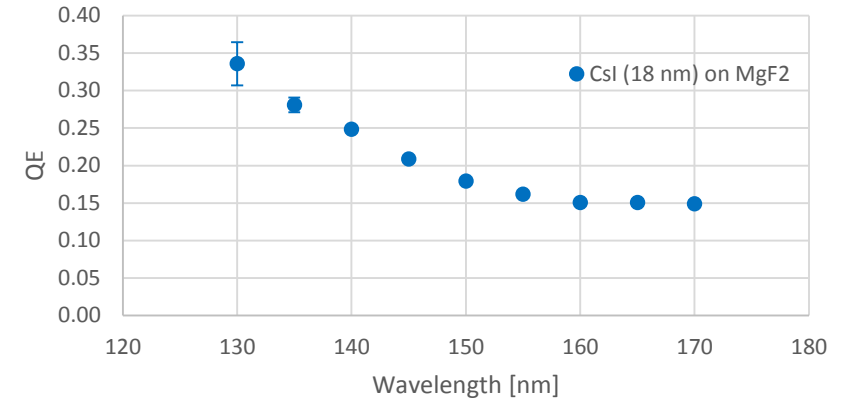
$I_{PMT}$  - current measured on PMT (offset subtracted)

$CalFac_{PMT}$  - calibration factor from calibrated CsI PMT (depends on wavelength)

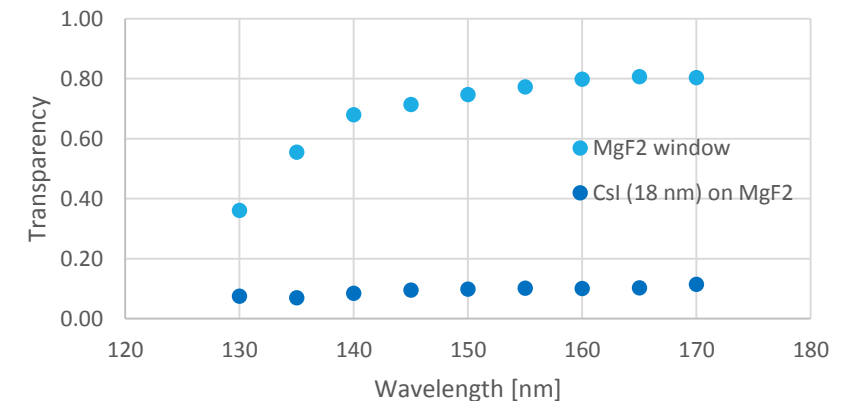
$e = 1.602 \cdot 10^{-19} [C]$  - elementary charge

- Transparency =  $\frac{PMT\ current:\ sample\ in}{PMT\ current:\ sample\ out}$

QE vs wavelength



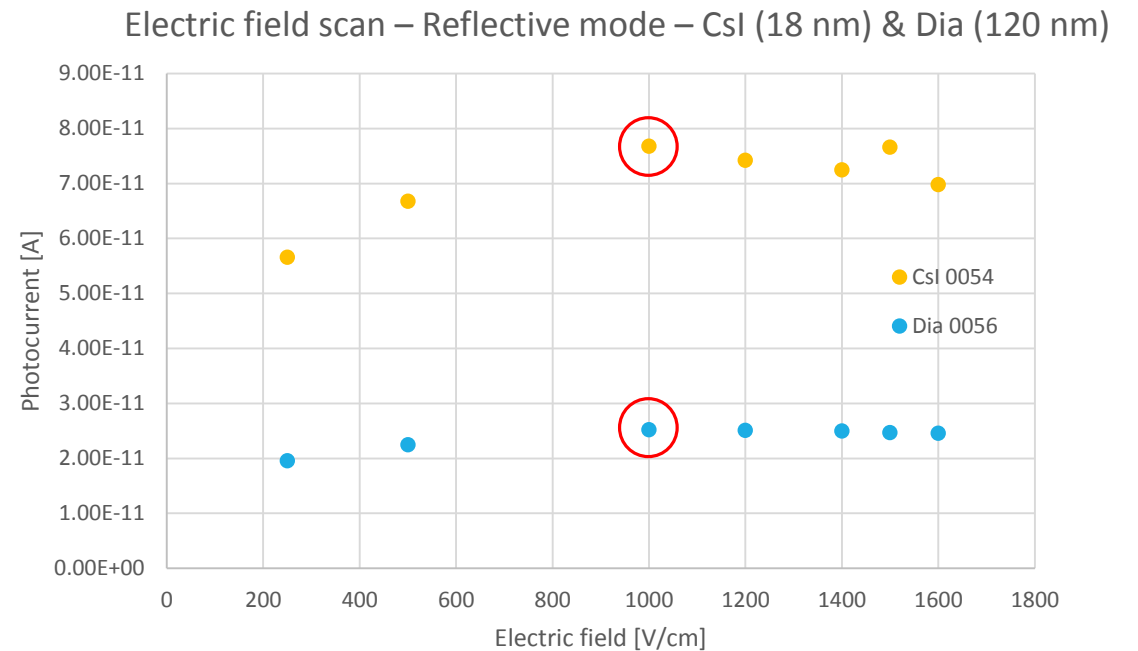
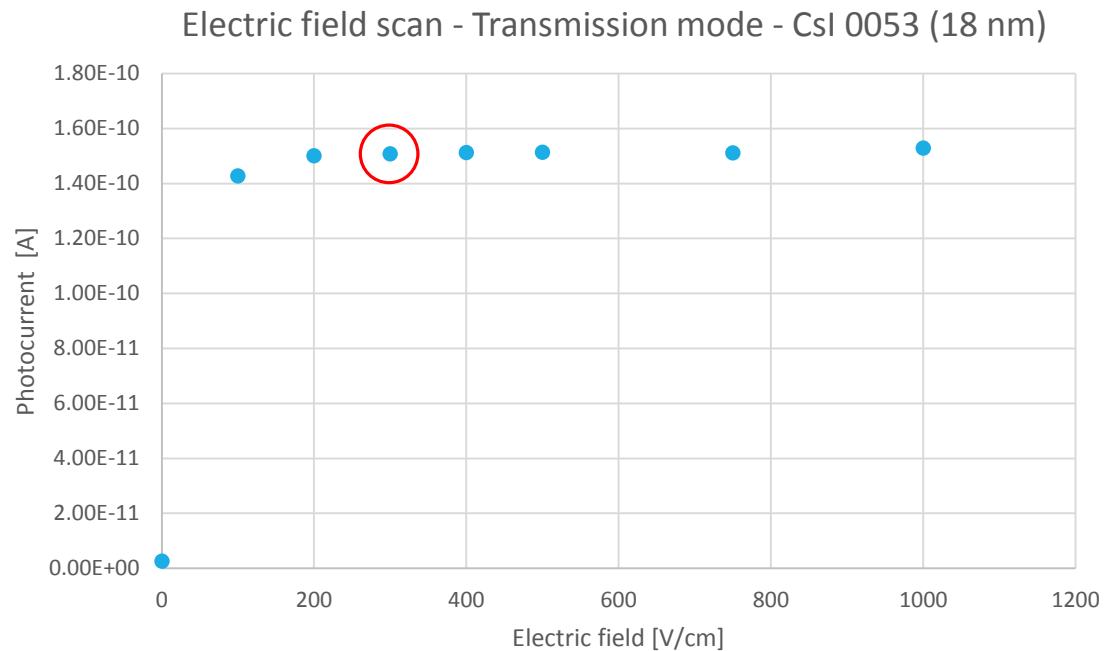
Transparency vs wavelength



# Electric field scanning

## Reflective/Transmission mode

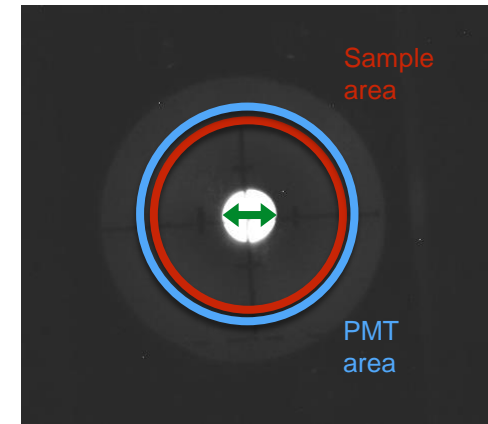
- To determine efficient extraction voltage for different samples.
- Photocurrent measured @ WL = 160 nm (+/- 5 nm).
- Drift gap: transmission mode: 1 cm; reflective mode: 0.5 cm.
- Electric field set at plateau: transmission mode: 300 V/cm (U = 300 V); reflective mode: 1000 V/cm (U = 500 V).



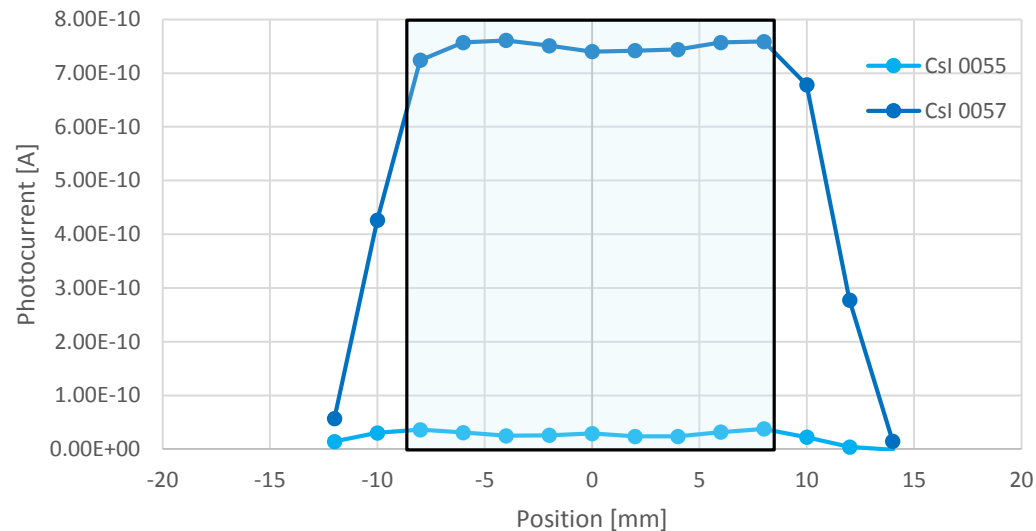
# QE uniformity scanning

## Reflective mode

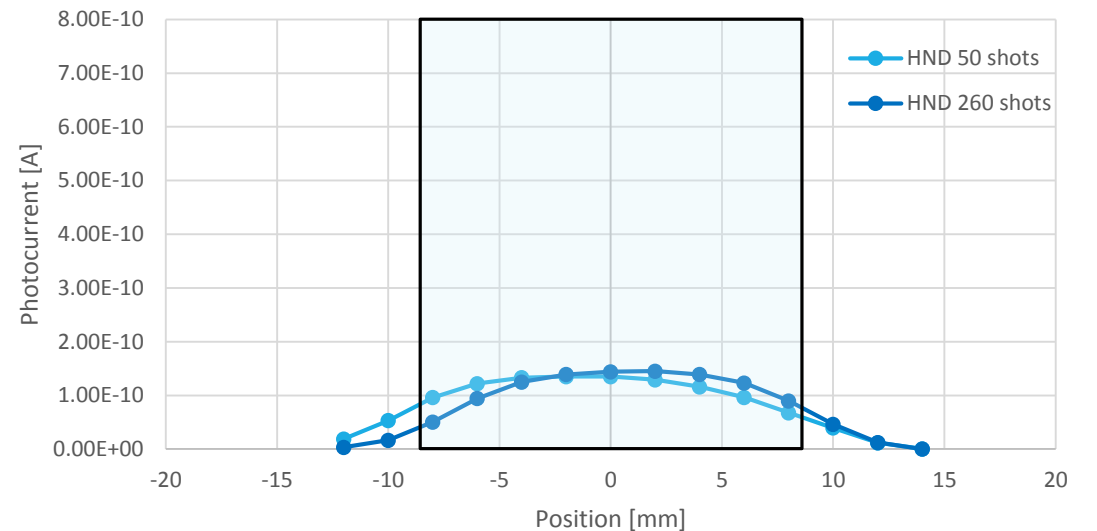
- UV beam dia. 5 mm; scanning area dia. 17 mm.
- Photocurrent measured @ WL = 160 nm (+- 5 nm).
- Samples: CsI (18 nm) and hydrogenated nanodiamonds (HND):  
*reference, T. Triloki: <https://indico.cern.ch/event/872501/contributions/3728175/>*
- Extraction grid: V = 500 V for CsI, V = 1000 V for HND on PCB.



Position scanning - CsI



Position scanning - HND on PCB



- CsI samples have profile with edges decreasing when spot is off sample.
- CsI 0055 has lower photocurrent than CsI 0057 due to degradation.

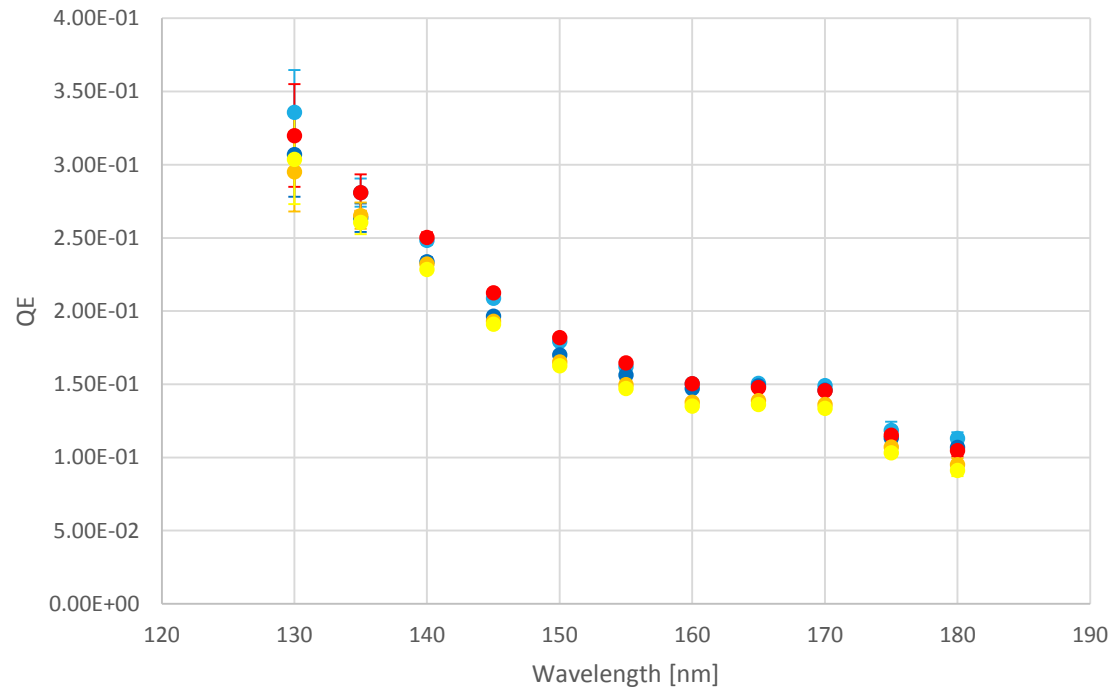
- HND on PCB samples have a gaussian shape profile.
- HND on PCB samples have lower photocurrent than CsI.

# Reproducibility

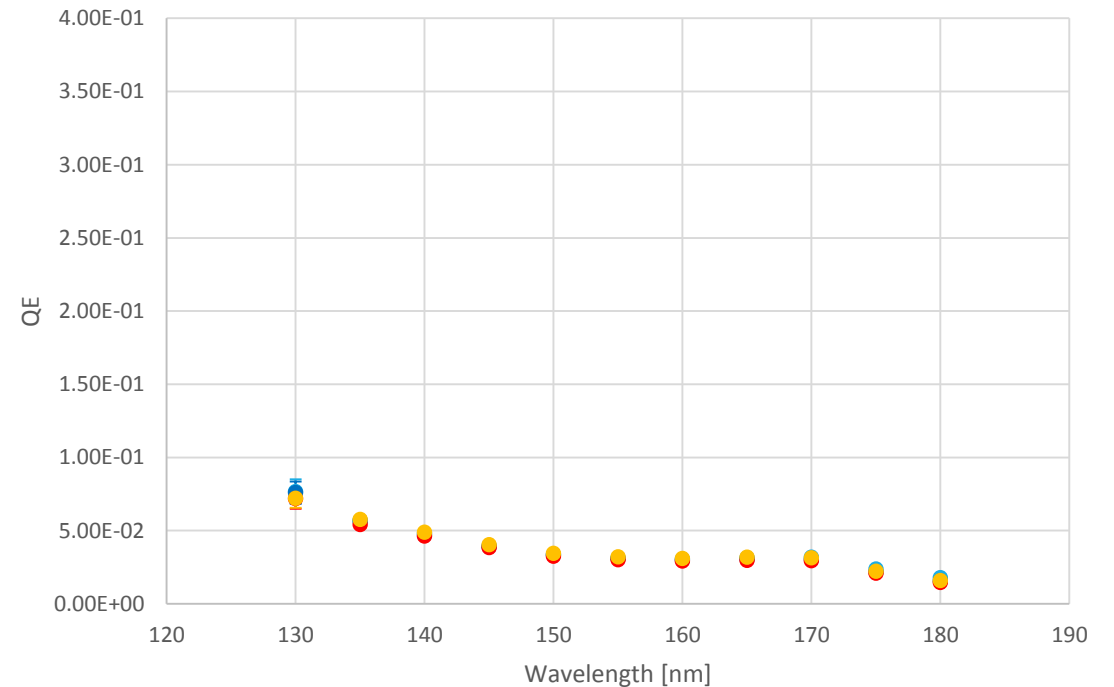
## Reflective/Transmission mode

- The results mostly overlaps.
- Minor fluctuations between measurements may come from: different amount of light, different pressure, CsI degradation...

QE Csl 0057 (18 nm) reproducibility



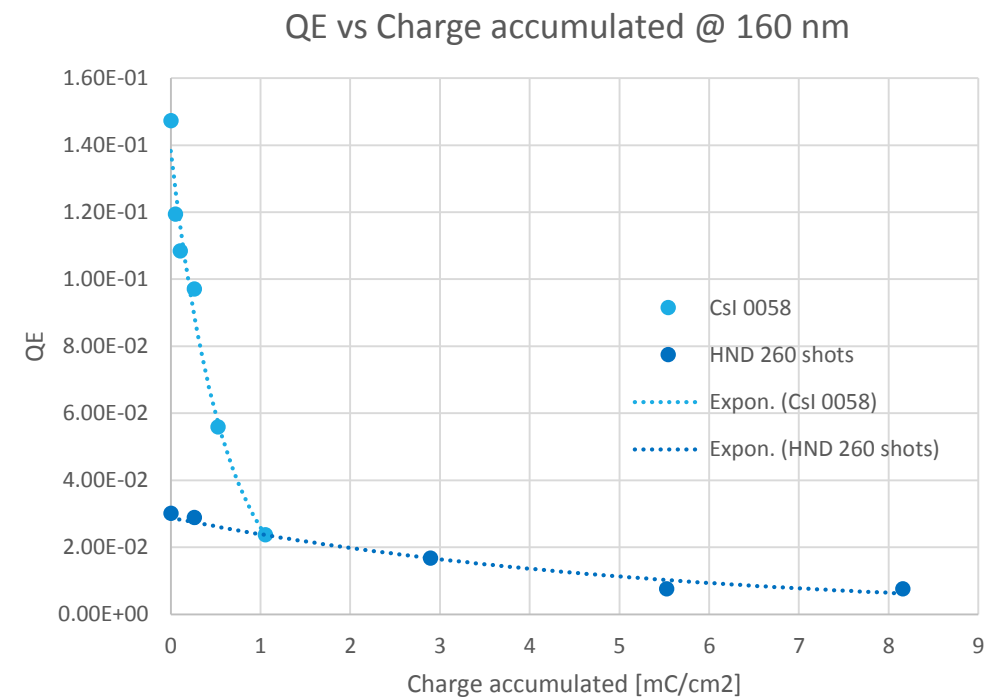
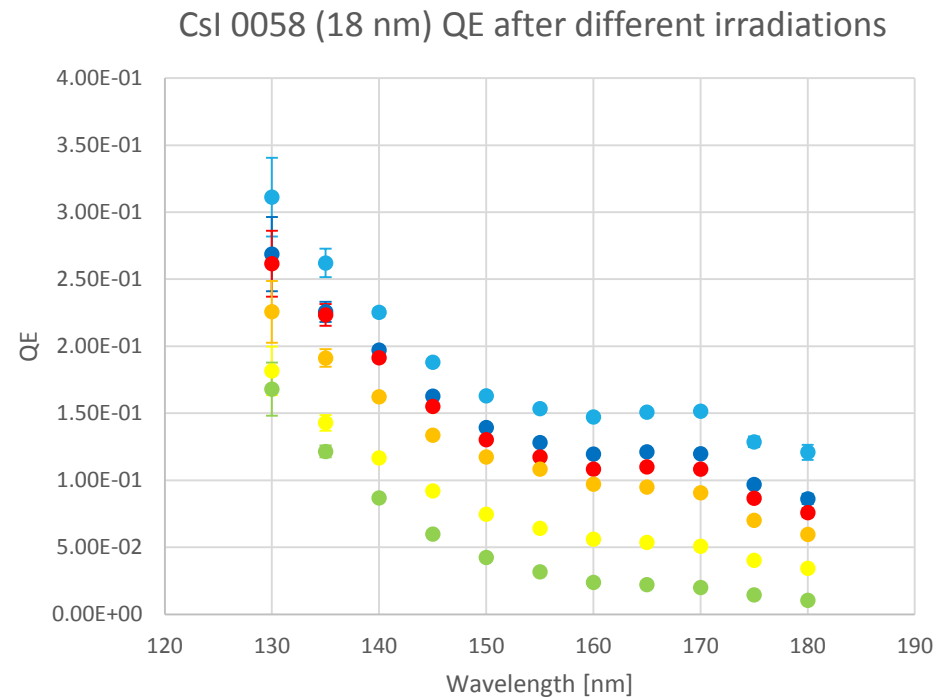
QE HND 50 shots on PCB reproducibility



# Ageing studies under ion bombardment

## Reflective mode

- Studies of the CsI (18 nm) and HND (260 shots) degradation due to ion bombardment.
- Sample: dia. 1 inch circle; accumulated charge normalized to  $cm^2$ .

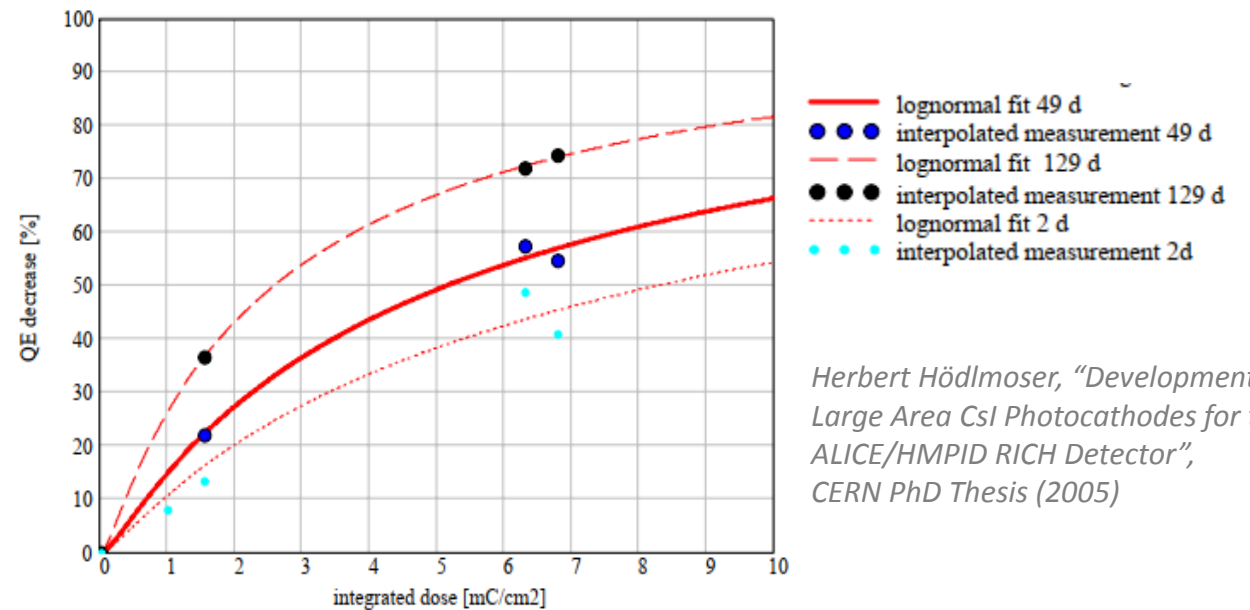
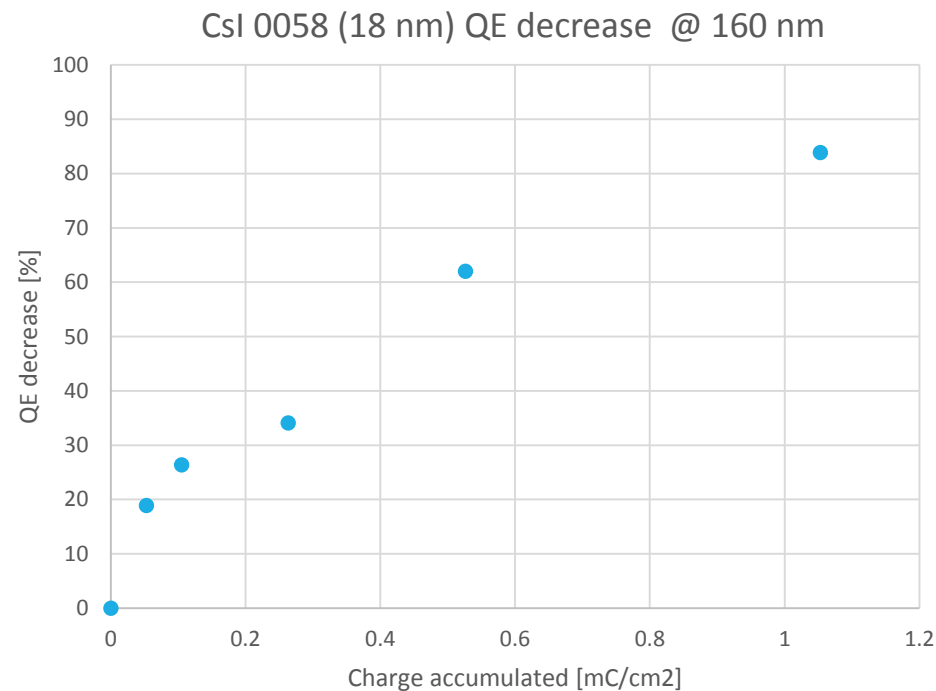


- Result: the dependence of QE vs charge accumulated has an exponential decay character.

# Ageing studies under ion bombardment

## Reflective mode

- Studies of the CsI (18 nm) degradation due to ion bombardment.
- Comparison of the QE decrease results with the literature.



*Herbert Hödlmoser, "Development of Large Area CsI Photocathodes for the ALICE/HMPID RICH Detector", CERN PhD Thesis (2005)*

- Future plans: new CsI samples with protection layers: LiF and MgF<sub>2</sub> (2 nm); another possibility: graphene layer.

# Automated M/I routine

## Reflective mode

- Fully automated LabVIEW procedure of measurements and irradiations of the samples in reflective mode.
- The interface allows to select:
  - task: M (measurement) or I (irradiation);
  - sample (S1, S2, S3);
  - charge to be accumulated (in case of irradiation).

The screenshot shows the Reflective Measurement interface. On the left is a table with columns 'M/I', 'Sample', and 'Charge [C]'. The first row has 'M' in the 'M/I' column and 'S1,S2' in the 'Sample' column. Below the table are three control elements: a text box with the message 'The first task has to be M (measurement)!', a 'NumberOfCurrentRow' spinner set to 0, a 'NumberOfValidRows' spinner set to 0, and an 'IsValidIrrad' indicator light which is currently off.

M/I	Sample	Charge [C]
M	S1,S2	
I	S1	0.001
M	S1	
I	S1	0.01
I	S2	
I	S3	0.01
M	S1	
M	S2	
I	S1	
I	S2	

This screenshot shows the same interface as the previous one, but with a red circle highlighting the table and the error message. The error message reads 'The first task has to be M (measurement)!'. Below the table, there are three columns of controls for samples S1, S2, and S3. Each column has a 'shouldAddCharge' indicator light (all are on), a 'shouldAddChargeValue' spinner (all are set to 0), and a 'totalIrradiatedCharge' spinner (all are set to 0). A 'Start the process' button is located below the table.

M/I	Sample	Charge
M	S1,S2	
I	S1	0.001
M	S1	
I	S1	0.01
I	S2	
I	S3	0.01
M	S1	
M	S2	
I	S1	
I	S2	



# Summary

- ASSET is a photocathode characterisation device used to:
  - Quantify the degradation of photocathodes when exposed to ion back flow.
  - Examine possible alternative photocathode materials as well as protective layers.
- The setup permits reflective and transmission mode measurements as well as irradiation studies.
- Performed measurement campaigns with:
  - DLC photocathodes (USTC),
  - B4C photocathodes (CEA Saclay),
  - CVD Diamond samples (RAS),
  - Nanodiamond photocathodes (INFN Trieste/Bari),
  - CsI photocathodes (CERN).
- Limitation and plans:
  - Increase sensitivity and wavelength range.
  - Possibly move to closer focus.
  - QE in gas measurements.

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  - QE in gas measurements.

Thank you for your attention 😊

# ASSET

## Backup

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# Collimating optics

To extend sensitivity and wavelength range

- Currently limited due to low amount of UV light focused onto sample.
- Simple collimating lens has strong wavelength-dependence of focal length.
- Most of the light lost due to defocusing:
  - limited sensitivity;
  - limited accessible wavelength range.
- Collimating/focusing chamber can significantly increase amount of light focused onto sample and thus extend sensitivity and accessible wavelength range:
  - no wavelength-dependence;
  - maintains focus.

